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				Application Number	09/879,658
				Filing Date	06/11/2001
				First Named Inventor	Ohkami
				Group Art Unit	2123
				Examiner Name	Unassigned
Sheet	1	of	1	Attorney Docket Number	706316.1178

MAY 08 2003

INFORMATION DISCLOSURE
STATEMENT BY APPLICANT

(use as many sheets as necessary)

U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publications of Cited Documents MM-DD-YYYY
		Number	Kind Code ²		
Ayul	AA	5,546,562		Patel	08/13/1996

FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publications of Cited Documents MM-DD-YYYY
		Office ³	Number ⁴	Kind Code ⁵		
Ayul	BA	EP	0 838 772	A2	Quickturn Design Systems, Inc.	04/29/1998
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS					
Examiner Initials ¹	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		T ₂			
Ayul	CA	KOCH G.H. et al, "Breakpoints and Breakpoint Detection in Source-level Emulation," ACM TRANSACTIONS ON DESIGN AUTOMATION OF ELECTRONIC SYSTEM, April 1998, Vol. 3, no. 2, pages 209-230			
Ayul	CB	KOCH, G.H. et al, "Debugging of Behavioral VHDL Specifications by Source Level Emulation" PROCEEDINGS EURO-DAC '95. EUROPEAN DESIGN AUTOMATION CONFERENCE WITH EURO-BHDL, PROCEEDINGS OF EURO-DAC. EUROPEAN DESIGN AUTOMATION CONFERENCE, Brighton, UK September 18-22, 1995			
Ayul	CC	POTKONJAK, M. et al, "Design-for-Debugging of Application Specific Designs" 1995 IEEE/ACM INTERNATIONAL CONFERENCE ON COMPUTER-AIDED DESIGN (ICCAD), San Jose, California November 5-9, 1995 and IEEE/ACM INTERNATIONAL CONFERENCE ON COMPUTER-AIDED DESIGN, Los Alamitos, California November 5, 1995			

Examiner Signature	DOCSOC1:136971.1 Ayul Sharon	Date Considered	1/8/2004
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent documents. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

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